Dual N-channel 80 V, 12 mOhm logic level MOSFET in LFPAK56D

12 December 2024

Product data sheet

1. General description

Dual N-channel logic level MOSFET in an LFPAK56D (Dual Power-SO8) package. This product has been designed and qualified to AEC-Q101 standard for use in high performance automotive applications.

2. Features and benefits

- Dual MOSFET two silicon dies in one LFPAK56D package for significant space saving
- Trench12 MOSFET technology
- Efficient switching with soft body-diode recovery
- Automotive qualified to AEC-Q101 at 175 °C
- · Side-wettable flanks for robust solder joints and automatic optical inspection

3. Applications

- 12 V 24 V and 48 V automotive systems
- · Motor, lighting, and solenoid control
- · Transmission control
- LED lighting
- Circuit protection

4. Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions		Min	Тур	Max	Unit	
Limiting valu	Limiting values FET1 and FET2							
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	-	80	V	
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[1]	-	-	51	А	
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	-	68	W	
Static chara	cteristics FET1 and FET2			'	'		·	
R _{DSon}	drain-source on-state resistance	$V_{GS} = 10 \text{ V}; I_D = 15 \text{ A}; T_j = 25 \text{ °C};$ Fig. 11		6.2	8.8	11.2	mΩ	
Dynamic cha	aracteristics FET1 and FE	T2		'	'		<u> </u>	
Q_{GD}	gate-drain charge	I _D = 15 A; V _{DS} = 40 V; V _{GS} = 5 V; T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>		1.3	4.4	9.7	nC	

^{[1] 51} A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.



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5. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	S1	source1	8 7 6 5	
2	G1	gate1	\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\\	D1 D1 D2 D2
3	S2	source2		
4	G2	gate2		
5	D2	drain2		
6	D2	drain2		
7	D1	drain1	1 2 3 4	S1 G1 S2 G2
8	D1	drain1	LFPAK56D; Dual LFPAK (SOT1205)	mbk725

6. Ordering information

Table 3. Ordering information

Type number	Package	ackage					
	Name	Description	Version				
BUK9K12-80L		plastic, single ended surface mounted package (LFPAK56D); 8 leads	SOT1205				

7. Marking

Table 4. Marking codes

Type number	Marking code
BUK9K12-80L	91280L

8. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134). Tj = 25 °C unless otherwise stated.

Symbol	Parameter	Conditions		Min	Max	Unit		
Limiting values	imiting values FET1 and FET2							
V _{DS}	drain-source voltage	25 °C ≤ T _j ≤ 175 °C		-	80	V		
V_{GS}	gate-source voltage		[1]	-20	20	V		
P _{tot}	total power dissipation	T _{mb} = 25 °C; <u>Fig. 1</u>		-	68	W		
I _D	drain current	V _{GS} = 10 V; T _{mb} = 25 °C; <u>Fig. 2</u>	[2]	-	51	А		
		V _{GS} = 10 V; T _{mb} = 100 °C; <u>Fig. 2</u>		-	36	Α		
I _{DM}	peak drain current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 °C$; Fig. 3		-	206	А		
T _{stg}	storage temperature			-55	175	°C		
Tj	junction temperature			-55	175	°C		
Source-drain diode FET1 and FET2								
Is	source current	T _{mb} = 25 °C		-	51	А		
I _{SM}	peak source current	pulsed; $t_p \le 10 \mu s$; $T_{mb} = 25 ^{\circ}C$		-	206	А		

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Symbol	Parameter	Conditions		Min	Max	Unit
Avalanche ruggedness FET1 and FET2						
E _{DS(AL)S}		I_D = 27.6 A; $V_{sup} \le 80$ V; R_{GS} = 50 Ω; V_{GS} = 5 V; $T_{j(init)}$ = 25 °C; unclamped; t_{AL} = 62 μs; Fig. 4	[3] [4]	-	88.9	mJ
I _{AS}	non-repetitive avalanche current	$V_{sup} = 80 \text{ V}; V_{GS} = 5 \text{ V}; T_{j(init)} = 25 \text{ °C};$ $R_{GS} = 50 \Omega; Fig. 4$	[3] [4]	-	27.6	А

- [1] Refer to application note AN90001 for further information.
- [2] 51 A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.
- [3] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C.
- [4] Refer to application note AN10273 for further information.

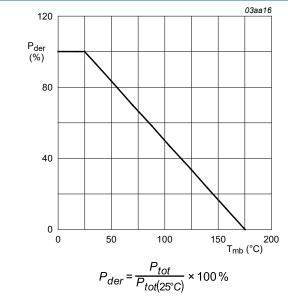
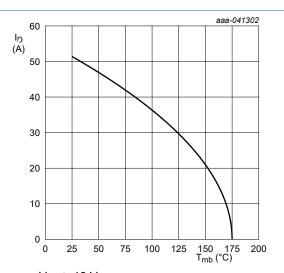


Fig. 1. Normalized total power dissipation as a function of mounting base temperature



 $V_{GS} \ge 10 \text{ V}$ 51 A continuous current has been successfully demonstrated during application tests. Practically the current will be limited by PCB, thermal design and operating temperature.

Fig. 2. Continuous drain current as a function of mounting base temperature, FET1 and FET2

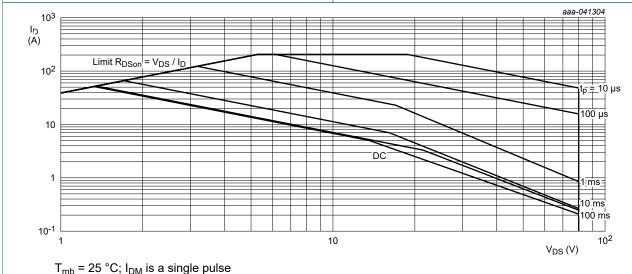
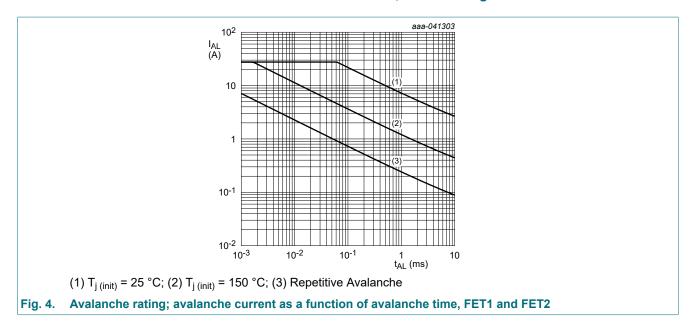


Fig. 3. Safe operating area; continuous and peak drain currents as a function of drain-source voltage, FET1 and FFT2

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9. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R _{th(j-mb)}	thermal resistance from junction to mounting base	<u>Fig. 5</u>	-	1.26	2.21	K/W

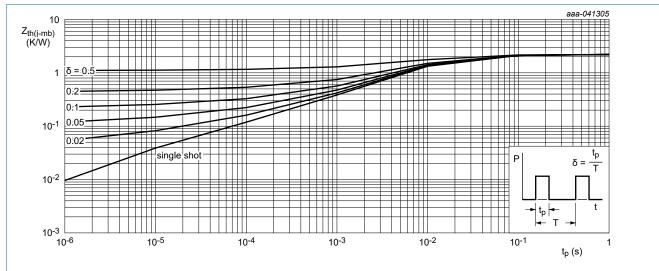


Fig. 5. Transient thermal impedance from junction to mounting base as a function of pulse duration, FET1 and FET2

Dual N-channel 80 V, 12 mOhm logic level MOSFET in LFPAK56D

10. Characteristics

Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static chara	acteristics FET1 and FET2				<u> </u>	
V _{(BR)DSS}	drain-source	I _D = 250 μA; V _{GS} = 0 V; T _j = 25 °C	80	90	-	V
	breakdown voltage	I _D = 250 μA; V _{GS} = 0 V; T _j = -40 °C	73.5	87	-	V
		I _D = 250 μA; V _{GS} = 0 V; T _j = -55 °C	72	86	-	V
V _{GS(th)}	gate-source threshold voltage	$I_D = 0.14 \text{ mA}; V_{DS}=V_{GS}; T_j = 25 \text{ °C};$ Fig. 9; Fig. 10	1.4	1.7	2.05	V
		$I_D = 0.14 \text{ mA}; V_{DS}=V_{GS}; T_j = 175 \text{ °C};$ Fig. 10	0.5	-	-	V
		$I_D = 0.14 \text{ mA}; V_{DS}=V_{GS}; T_j = -55 \text{ °C};$ Fig. 10	-	-	2.45	V
I _{DSS}	drain leakage current	V _{DS} = 80 V; V _{GS} = 0 V; T _j = 25 °C	-	0.02	1	μA
		V _{DS} = 80 V; V _{GS} = 0 V; T _j = 125 °C	-	6	100	μA
		V _{DS} = 80 V; V _{GS} = 0 V; T _j = 175 °C	-	70	500	μA
I _{GSS}	gate leakage current	V _{GS} = 20 V; V _{DS} = 0 V; T _j = 25 °C	-	2	150	nA
		V _{GS} = -20 V; V _{DS} = 0 V; T _j = 25 °C	-	2	150	nA
R _{DSon}	drain-source on-state resistance	V _{GS} = 10 V; I _D = 15 A; T _j = 25 °C; Fig. 11	6.2	8.8	11.2	mΩ
		V_{GS} = 10 V; I_D = 15 A; T_j = 100 °C; Fig. 12	9.1	13.5	18	mΩ
		V _{GS} = 10 V; I _D = 15 A; T _j = 125 °C; Fig. 12	10	15	20	mΩ
		V_{GS} = 10 V; I_{D} = 15 A; T_{j} = 175 °C; Fig. 12	12.1	18.7	25.6	mΩ
		V_{GS} = 4.5 V; I_{D} = 15 A; T_{j} = 25 °C; Fig. 11	7.9	11.4	17	mΩ
		V_{GS} = 4.5 V; I_{D} = 15 A; T_{j} = 100 °C; Fig. 12	11.6	17.5	27.2	mΩ
		V_{GS} = 4.5 V; I_{D} = 15 A; T_{j} = 125 °C; Fig. 12	12.7	19.3	30.2	mΩ
		V _{GS} = 4.5 V; I _D = 15 A; T _j = 175 °C; Fig. 12	15.4	24.2	39	mΩ
R_G	gate resistance	f = 1 MHz; T _j = 25 °C	0.9	1.7	3.4	Ω
Dynamic ch	naracteristics FET1 and FE	ET2				
$Q_{G(tot)}$	total gate charge	I _D = 15 A; V _{DS} = 40 V; V _{GS} = 5 V; T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>	11	22	33	nC
		I _D = 15 A; V _{DS} = 40 V; V _{GS} = 10 V; T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>	22	44	66	nC
Q _{GS}	gate-source charge	I _D = 15 A; V _{DS} = 40 V; V _{GS} = 5 V;	5	8.4	11.8	nC
Q_{GD}	gate-drain charge	T _j = 25 °C; <u>Fig. 13</u> ; <u>Fig. 14</u>	1.3	4.4	9.7	nC
$V_{GS(pl)}$	gate-source plateau voltage	I _D = 15 A; V _{DS} = 40 V; T _j = 25 °C; Fig. 13; Fig. 14	-	2.9	-	V
C _{iss}	input capacitance	V _{DS} = 25 V; V _{GS} = 0 V; f = 1 MHz;	1903	3172	4441	pF
C _{oss}	output capacitance	T _j = 25 °C; <u>Fig. 15</u>	430	717	1147	pF
C _{rss}	reverse transfer capacitance		14.8	37	59.2	pF

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Symbol	Parameter	Conditions		Min	Тур	Max	Unit
t _{d(on)}	turn-on delay time	$V_{DS} = 40 \text{ V}; R_L = 2.6 \Omega; V_{GS} = 5 \text{ V};$		-	19.5	-	ns
t _r	rise time	$R_{G(ext)} = 5 \Omega; T_j = 25 °C$		-	22.5	-	ns
t _{d(off)}	turn-off delay time			-	26	-	ns
t _f	fall time	1		-	15	-	ns
Source-dra	in diode FET1 and FET2			•			<u>'</u>
V_{SD}	source-drain voltage	$I_S = 15 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ °C}; Fig. 16$		-	0.88	1	V
t _{rr}	reverse recovery time	$I_S = 15 \text{ A}$; $dI_S/dt = -100 \text{ A/}\mu\text{s}$; $V_{GS} = 0 \text{ V}$;		-	55	-	ns
Q _r	recovered charge	V _{DS} = 40 V; T _j = 25 °C; <u>Fig. 17</u>		-	38	-	nC

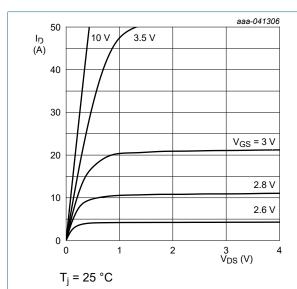


Fig. 6. Output characteristics; drain current as a function of drain-source voltage; typical values, FET1 and FET2

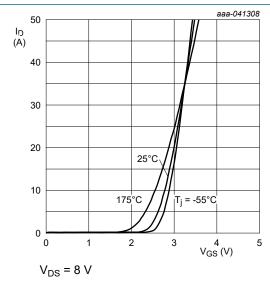


Fig. 8. Transfer characteristics; drain current as a function of gate-source voltage; typical values, FET1 and FET2

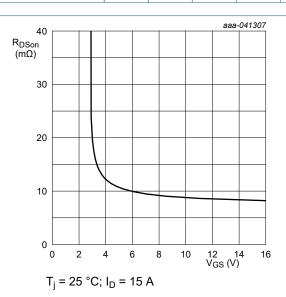


Fig. 7. Drain-source on-state resistance as a function of gate-source voltage; typical values, FET1 and FET2

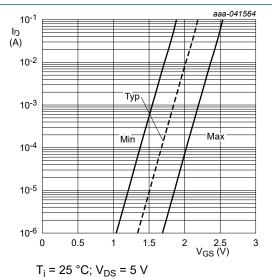


Fig. 9. Sub-threshold drain current as a function of gate-source voltage, FET1 and FET2

Dual N-channel 80 V, 12 mOhm logic level MOSFET in LFPAK56D

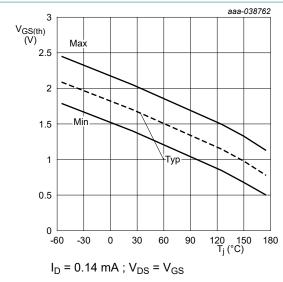


Fig. 10. Gate-source threshold voltage as a function of junction temperature, FET1 and FET2

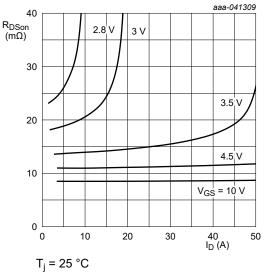


Fig. 11. Drain-source on-state resistance as a function of drain current; typical values, FET1 and FET2

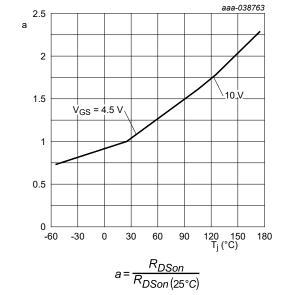


Fig. 12. Normalized drain-source on-state resistance factor as a function of junction temperature, FET1 and FET2

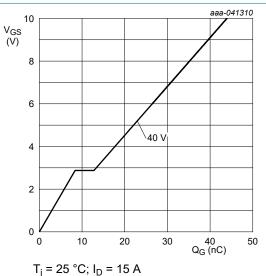


Fig. 13. Gate-source voltage as a function of gate charge; typical values, FET1 and FET2

Dual N-channel 80 V, 12 mOhm logic level MOSFET in LFPAK56D

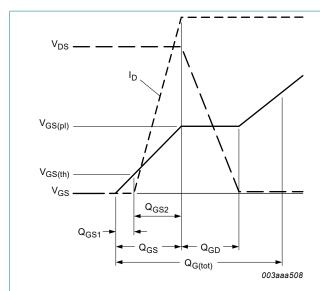
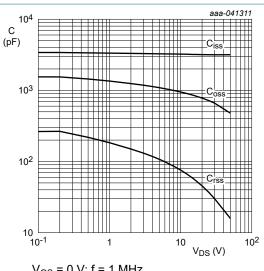


Fig. 14. Gate charge waveform definitions



 $V_{GS} = 0 V; f = 1 MHz$

Fig. 15. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values, FET1 and FET2

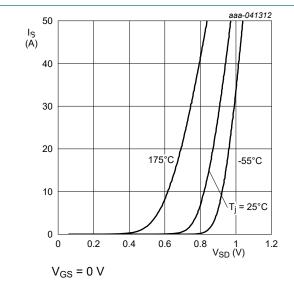


Fig. 16. Source-drain (diode forward) current as a function of source-drain (diode forward) voltage; typical values, FET1 and FET2

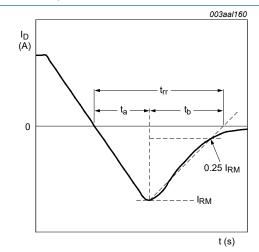


Fig. 17. Reverse recovery timing definition

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11. Package outline

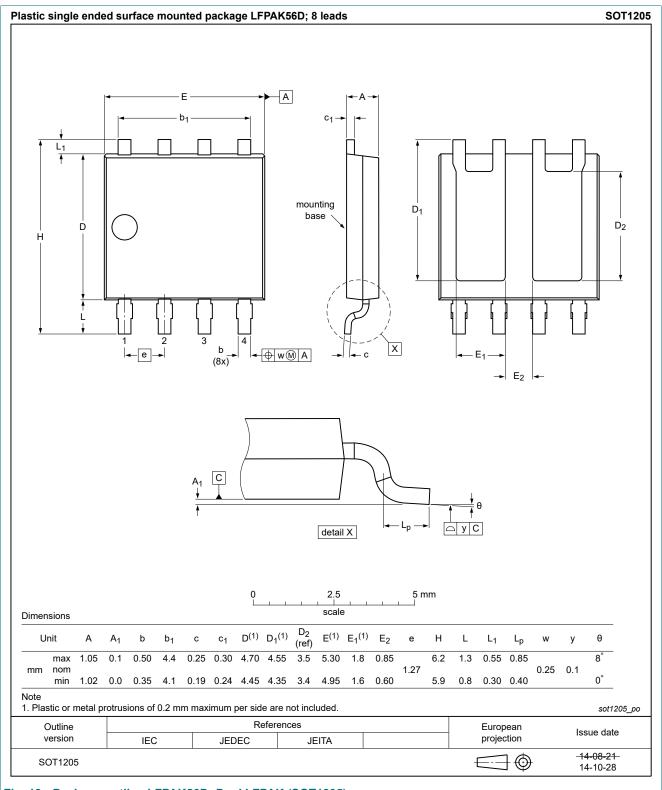


Fig. 18. Package outline LFPAK56D; Dual LFPAK (SOT1205)

Dual N-channel 80 V, 12 mOhm logic level MOSFET in LFPAK56D

12. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
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Product [short] data sheet	Production	This document contains the product specification.

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BUK9K12-80L

Dual N-channel 80 V, 12 mOhm logic level MOSFET in LFPAK56D

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